

<b>Notice of References Cited</b>	Application/Control No. 10/517,283	Applicant(s)/Patent Under Reexamination BUJARD ET AL.	
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*	B	US-2005/0013934	01-2005	Xiong et al.	427/212
*	C	US-2006/0042507	03-2006	Bujard et al.	106/415
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	M	US-			

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*Patricia L. Hailey*